

. . eescale Semiconductor
Technical Data

Document Number: MML09231H Rev. 1, 9/2014

## **√**RoHS

# Enhancement Mode pHEMT Technology (E-pHEMT)

# Low Noise Amplifier

The MML09231H is a single-stage low noise amplifier (LNA) with active bias and high isolation for use in cellular infrastructure applications. It is designed for a range of low noise, high linearity applications such as small cell, tower mounted amplifiers (TMA) and receiver front-end circuits. It operates from a single voltage supply and is suitable for applications with frequencies from 700 to 1400 MHz such as ISM, GSM, W-CDMA and LTE.

#### **Features**

- Ultra Low Noise Figure: 0.36 dB @ 900 MHz
- Frequency: 700-1400 MHz
- Unconditionally Stable Over Temperature
- High Reverse Isolation: -21 dB @ 900 MHz
- P1dB: 24.5 dBm @ 900 MHz
- Small-Signal Gain: 17.2 dB @ 900 MHz (adjustable externally)
- · Third Order Output Intercept Point: 37.4 dBm @ 900 MHz
- · Single 5 V Supply
- · Power-down Pin
- Supply Current: 55 mA
- 50 Ohm Operation (some external matching required)
- · Cost-effective 8-pin, 2 mm DFN Surface Mount Plastic Package
- In Tape and Reel. T1 Suffix = 1,000 Units, 12 mm Tape Width, 7-inch Reel.

#### Table 1. Typical Performance (1)

Characteristic	Symbol	700 MHz	900 MHz	1400 MHz	Unit
Noise Figure (2a)	NF	0.46 <b>(b)</b>	0.36(b)	0.45 <b>(b)</b>	dB
Input Return Loss (S11)	IRL	-17	-15	-14	dB
Output Return Loss (S22)	ORL	-14	-15	-15	dB
Small-Signal Gain (S21)	G <sub>p</sub>	19	17.2	13.2	dB
Power Output @ 1dB Compression	P1dB	24	24.5	24	dBm
Third Order Input Intercept Point	IIP3	17	20.2	23.8	dBm
Third Order Output Intercept Point	OIP3	36	37.4	37	dBm

# 1. $V_{DD} = 5$ Vdc, $T_A = 25$ °C, 50 ohm system, application circuit tuned for specified frequency.

# MML09231HT1

700-1400 MHz, 17.2 dB 24.5 dBm, 0.36 dB NF E-pHEMT LNA



DFN 2 ×

#### **Table 2. Maximum Ratings**

Rating	Symbol	Value	Unit
Supply Voltage	$V_{DD}$	6	V
Supply Current	I <sub>DD</sub>	150	mA
RF Input Power	P <sub>in</sub>	20	dBm
Storage Temperature Range	T <sub>stg</sub>	-65 to +150	°C
Junction Temperature	T <sub>J</sub>	175	°C

#### **Table 3. Thermal Characteristics**

Characteristic	Symbol	Value <sup>(3)</sup>	Unit
Thermal Resistance, Junction to Case Case Temperature 95°C, 5 Vdc, 55 mA, no RF applied	$R_{ heta JC}$	77	°C/W

Refer to AN1955, Thermal Measurement Methodology of RF Power Amplifiers. Go to <a href="http://www.freescale.com/rf">http://www.freescale.com/rf</a>.
 Select Documentation/Application Notes - AN1955.



<sup>2. (</sup>a) Noise figure value calculated with connector losses removed. (b)  $Z_{\text{in}}$  = 50  $\Omega.$ 



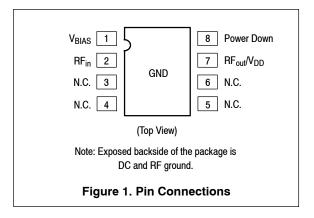
 $\textbf{Table 4. Electrical Characteristics} \ (V_{DD} = 5 \ \text{Vdc}, \ 900 \ \text{MHz}, \ T_{A} = 25^{\circ}\text{C}, \ 50 \ \text{ohm system, in Freescale Application Circuit})$ 

Characteristic	Symbol	Min	Тур	Max	Unit
Small-Signal Gain (S21)	Gp	15.8	17.2	_	dB
Input Return Loss (S11)	IRL	_	-15	_	dB
Output Return Loss (S22)	ORL	_	-15	_	dB
Power Output @ 1dB Compression	P1dB	_	24.5	_	dBm
Third Order Input Intercept Point	IIP3	_	20.2	_	dBm
Third Order Output Intercept Point	OIP3	_	37.4	_	dBm
Reverse Isolation (S12)	S12	_	-21	_	dB
Noise Figure (1)	NF	=	0.36	=	dB
Supply Current (2)	I <sub>DD</sub>	40	55	70	mA
Supply Voltage	$V_{DD}$	=	5	=	V
Supply Current in Power Down Mode	I <sub>PD</sub>	=	1.1	=	mA
Logic Voltage for Power Down <sup>(3)</sup> Input High Voltage Input Low Voltage	V <sub>PD</sub>	2.2 0	_ _	V <sub>DD</sub> 0.5	V

- 1. Noise figure value calculated with connector losses removed.
- 2. DC current measured with no RF signal applied.
- 3. Limits derived from device characterization.

**Table 5. Functional Pin Description** 

Pin Number	Pin Function
1	V <sub>BIAS</sub>
2	RF <sub>in</sub>
3	No Connection
4	No Connection
5	No Connection
6	No Connection
7	RF <sub>out</sub> /Supply Voltage
8	Power Down (active high)



#### **Table 6. ESD Protection Characteristics**

Test Methodology	Class
Human Body Model (per JESD 22-A114)	1B, passes 700 V
Machine Model (per EIA/JESD 22-A115)	A
Charge Device Model (per JESD 22-C101)	IV

# Table 7. Moisture Sensitivity Level

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD22-A113, IPC/JEDEC J-STD-020	1	260	°C



### **50 OHM APPLICATION CIRCUIT: 900 MHz**

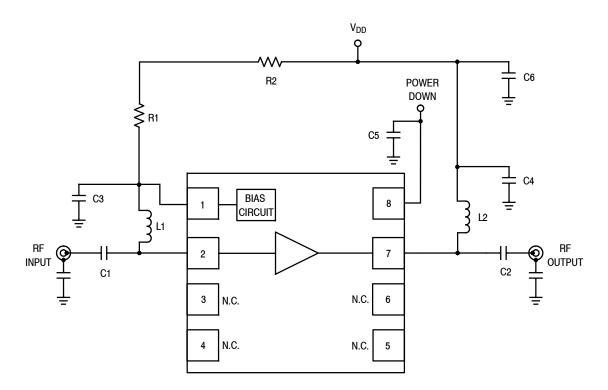


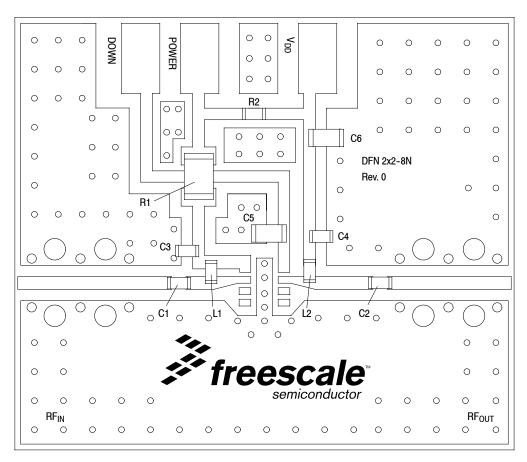
Figure 2. MML09231H Test Circuit Schematic

Table 8. MML09231H Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
C1	100 pF Chip Capacitor	GRM1555C1H101JA01	Murata
C2	180 pF Chip Capacitor	GRM1555C1H181JA01	Murata
C3	27 pF Chip Capacitor	GRM1555C1H270JA01	Murata
C4	220 pF Chip Capacitor	GRM1555C1H221JA01	Murata
C5, C6	1000 pF Chip Capacitors	GRM1885C1H102JA01	Murata
L1	20 nH Chip Inductor	0402HP-20NXGLW	Coilcraft
L2	47 nH Chip Inductor	0402HP-47NXGLW	Coilcraft
R1	4.7 kΩ, 1/10 W Chip Resistor	CR21-472J-B	Kyocera
R2	0 Ω, 1 A Chip Resistor	CR0402-J/-000GLFCT	Bourns
PCB	$0.02'',  \epsilon_{\rm f} = 3.50$	RO4350B	Rogers



#### **50 OHM APPLICATION CIRCUIT: 900 MHz**



NOTE: To achieve optimal noise performance, it is critical that proper biasing, input matching, supply decoupling and grounding are employed.

Figure 3. MML09231H Test Circuit Component Layout

Table 8. MML09231H Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
C1	100 pF Chip Capacitor	GRM1555C1H101JA01	Murata
C2	180 pF Chip Capacitor	GRM1555C1H181JA01	Murata
C3	27 pF Chip Capacitor	GRM1555C1H270JA01	Murata
C4	220 pF Chip Capacitor	GRM1555C1H221JA01	Murata
C5, C6	1000 pF Chip Capacitors	GRM1885C1H102JA01	Murata
L1	20 nH Chip Inductor	0402HP-20NXGLW	Coilcraft
L2	47 nH Chip Inductor	0402HP-47NXGLW	Coilcraft
R1	4.7 kΩ, 1/10 W Chip Resistor	CR21-472J-B	Kyocera
R2	0 Ω, 1 A Chip Resistor	CR0402-J/-000GLFCT	Bourns
PCB	$0.02''$ , $\epsilon_r = 3.50$	RO4350B	Rogers

(Test Circuit Component Designations and Values repeated for reference.)



#### 50 OHM TYPICAL CHARACTERISTICS: 900 MHz

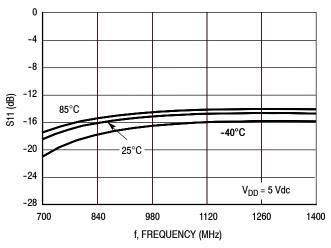


Figure 4. S11 versus Frequency versus Temperature

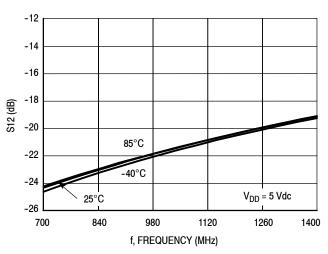


Figure 5. S12 versus Frequency versus Temperature

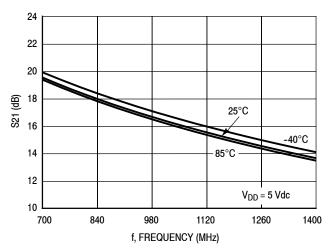


Figure 6. S21 versus Frequency versus Temperature

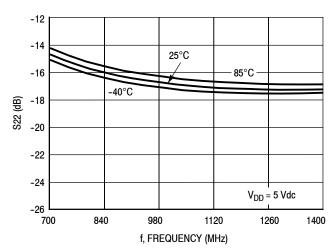


Figure 7. S22 versus Frequency versus Temperature



#### **50 OHM TYPICAL CHARACTERISTICS: 900 MHz**

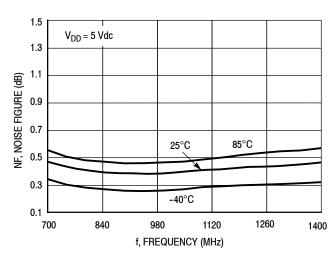


Figure 8. Noise Figure versus Frequency versus Temperature

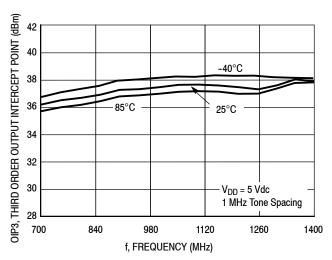


Figure 9. Third Order Output Intercept Point (Two-Tone) versus Frequency versus Temperature

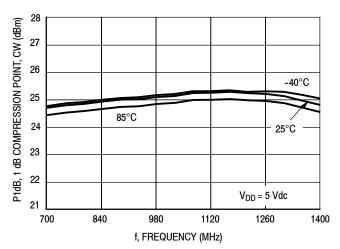


Figure 10. P1dB versus Frequency versus Temperature, CW



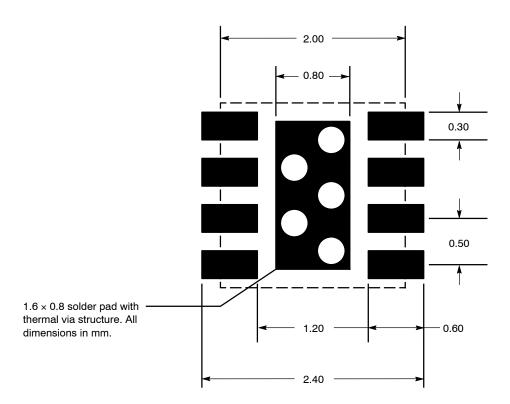


Figure 11. PCB Pad Layout for DFN 2  $\times$  2

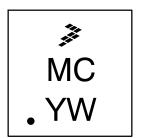
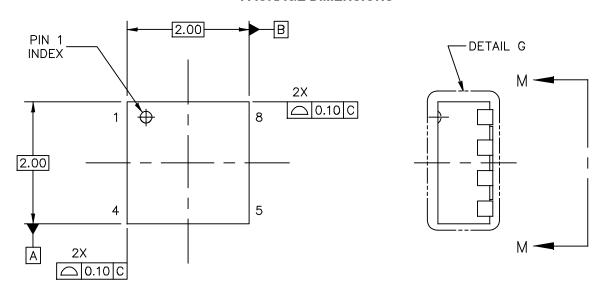
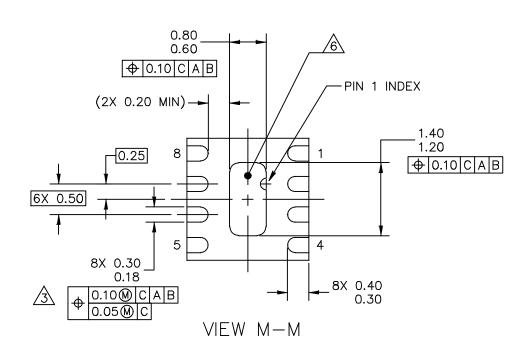


Figure 12. Product Marking



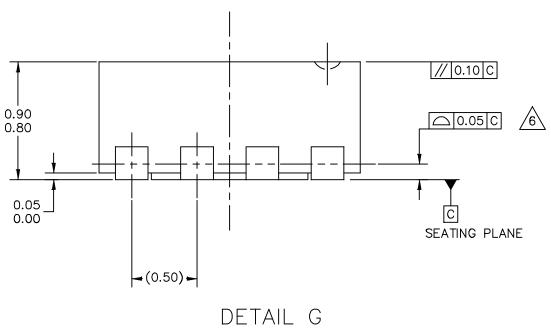
#### **PACKAGE DIMENSIONS**





© FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED.	MECHANICAL OUTLINE		PRINT VERSION NO	T TO SCALE
TITLE: THERMALLY ENHANCED DUAL FLAT NON-LEADED PACKAGE (DFN)		DOCUMENT NO: 98ASA00228D REV: 0		REV: 0
		CASE NUMBER: 2132-01 14 MAY 201		
8 TERMINAL, 0.5 PITCH (2 X	2 X 0.85)	STANDARD: NON-JEDEC		





$\Box$	ET	AIL	_	G	
VIEW	ROT.	ATED	9(	Э.	CW

© FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED.	MECHANICAL OUTLINE		PRINT VERSION NO	T TO SCALE
TITLE: THERMALLY ENHANCED DUAL FLAT NON-LEADED PACKAGE (DFN)		DOCUMENT NO	): 98ASA00228D	REV: 0
		CASE NUMBER: 2132-01 14 MAY 2010		
8 TERMINAL, 0.5 PITCH (2 X	2 X 0.85)	STANDARD: NON-JEDEC		



#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5 2009
- 2. ALL DIMENSIONS ARE IN MILLIMETERS.
- THIS DIMENSION APPLIES TO METALLIZED TERMINAL AND IS MEASURED BETWEEN 0.15
  AND 0.30mm FROM TERMINAL TIP. IF THE TERMINAL HAS THE OPTIONAL RADIUS ON THE
  OTHER END OF THE TERMINAL, THIS DIMENSION SHOULD NOT BE MEASURED IN THAT
  RADIUS AREA.
- 4. MAX. PACKAGE WARPAGE IS 0.05 mm.
- 5. MAXIMUM ALLOWABLE BURRS IS 0.076 mm IN ALL DIRECTIONS.
- 6. BILATERAL COPLANARITY ZONE APPLIES TO THE EXPOSED HEAT SINK SLUGAS WELL AS THE TERMINALS.

© FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED.	MECHANICAL OUTLINE		PRINT VERSION NOT TO SCALE	
TITLE: THERMALLY ENHANCED DUAL FLAT NON-LEADED PACKAGE (DFN) 8 TERMINAL, 0.5 PITCH (2 X 2 X 0.85)		DOCUMENT NO: 98ASA00228D		REV: 0
		CASE NUMBER	2: 2132–01	14 MAY 2010
		STANDARD: NON-JEDEC		



#### PRODUCT DOCUMENTATION, SOFTWARE AND TOOLS

Refer to the following resources to aid your design process.

#### **Application Notes**

AN1955: Thermal Measurement Methodology of RF Power Amplifiers

#### Software

.s2p File

#### **Development Tools**

· Printed Circuit Boards

For Software and Tools, do a Part Number search at http://www.freescale.com, and select the "Part Number" link. Go to Software & Tools on the part's Product Summary page to download the respective tool.

#### **FAILURE ANALYSIS**

At this time, because of the physical characteristics of the part, failure analysis is limited to electrical signature analysis. In cases where Freescale is contractually obligated to perform failure analysis (FA) services, full FA may be performed by third party vendors with moderate success. For updates contact your local Freescale Sales Office.

#### **REVISION HISTORY**

The following table summarizes revisions to this document.

Revision	Date	Description
0	May 2013	Initial Release of Data Sheet
1	Sept. 2014	Table 2, Maximum Ratings: updated Junction Temperature from 150°C to 175°C to reflect recent test results of the device, p. 1



#### How to Reach Us:

Home Page: freescale.com

Web Support: freescale.com/support

Information in this document is provided solely to enable system and software implementers to use Freescale products. There are no express or implied copyright licenses granted hereunder to design or fabricate any integrated circuits based on the information in this document.

Freescale reserves the right to make changes without further notice to any products herein. Freescale makes no warranty, representation, or guarantee regarding the suitability of its products for any particular purpose, nor does Freescale assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters that may be provided in Freescale data sheets and/or specifications can and do vary in different applications, and actual performance may vary over time. All operating parameters, including "typicals," must be validated for each customer application by customer's technical experts. Freescale does not convey any license under its patent rights nor the rights of others. Freescale sells products pursuant to standard terms and conditions of sale, which can be found at the following address: freescale.com/SalesTermsandConditions.

Freescale and the Freescale logo are trademarks of Freescale Semiconductor, Inc., Reg. U.S. Pat. & Tm. Off. All other product or service names are the property of their respective owners.

© 2013-2014 Freescale Semiconductor, Inc.



Document Number: MML09231H

Rev. 1, 9/2014